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FDD2670

200V N-Channel PowerTrench® MOSFET

General Description

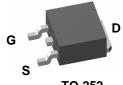
MOSFET has been designed N-Channel specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

These MOSFET's feature faster switching and lower gate charge than other MOSFET's with comparable $\ensuremath{\mathsf{RDS}}_{(\ensuremath{\mathsf{ON}})}$ specifications.

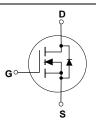
The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 3.6 A, 200 V. $R_{DS(ON)} = 130 \text{ m}\Omega$ @ $V_{GS} = 10 \text{ V}$
- Low gate charge
- Fas t switching speed
- High performance trench technology for extremely low R_{DS(ON)}
- · High power and current handling capability







Absolute Maximum Ratings T_A=25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|---|-----------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | 200 | V |
| V _{GSS} | Gate-Source Voltage | | ±20 | V |
| I _D | Drain Current - Continuous | (Note 1) | 3.6 | Α |
| | Drain Current - Pulsed | | 20 | |
| P _D | Maximum Power Dissipation @ T _C = 25°C | (Note 1) | 70 | W |
| | @ T _A = 25°C | (Note 1a) | 3.2 | |
| | @ T _A = 25°C | (Note 1b) | 1.3 | |
| dv/dt | Peak Diode Recovery dv/dt | (Note 3) | 3.2 | V/ns |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to +150 | °C |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | (Note 1) | 1.8 | °C/W |
|-----------------|---|-----------|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | (Note 1b) | 96 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape width | Quantity |
|----------------|---------|-----------|------------|------------|
| FDD2670 | FDD2670 | 13" | 16mm | 2500 units |

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---------------------------------------|--|---|-----|------------|------------|-------|
| Drain-So | ource Avalanche Ratings (Note | 1) | | I | | |
| W _{DSS} | Single Pulse Drain-Source Avalanche Energy | $V_{DD} = 100 \text{ V}, I_D = 3.6 \text{ A}$ | | | 375 | mJ |
| I _{AR} | Maximum Drain-Source Avalanche Current | | | | 3.6 | Α |
| Off Char | acteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$ | 200 | | | V |
| ΔBV _{DSS} ΔT _J | Breakdown Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | 214 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 160 V, V _{GS} = 0 V | | | 1 | μΑ |
| I _{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$ | | | 100 | NA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$ | | | -100 | NA |
| On Char | acteristics (Note 2) | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 2 | 4 | 4.5 | V |
| $\Delta V_{GS(th)} \ \Delta T_J$ | Gate Threshold Voltage Temperature Coefficient | I_D = 250 μ A, Referenced to 25°C | | -10 | | mV/°C |
| R _{DS(on)} | Static Drain–Source On–Resistance | V _{GS} = 10 V, I _D = 3.6 A V _{GS} = 10 V, I _D = 3.6 A T _J = 125°C | | 100 205 | 130 275 | mΩ |
| I _{D(on)} | On–State Drain Current | $V_{GS} = 10 \text{ V}, \qquad V_{DS} = 5 \text{ V}$ | 20 | | | Α |
| g FS | Forward Transconductance | $V_{DS} = 5 \text{ V}, \qquad I_{D} = 3.6 \text{ A}$ | | 15 | | S |
| Dynamic | : Characteristics | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = 100 \text{ V}, \qquad V_{GS} = 0 \text{ V},$ | | 1228 | | PF |
| Coss | Output Capacitance | f = 1.0 MHz | | 112 | | PF |
| C _{rss} | Reverse Transfer Capacitance | | | 17 | | pF |
| Switchin | g Characteristics (Note 2) | | | | | |
| $t_{\text{d(on)}}$ | Turn-On Delay Time | $V_{DD} = 100 \text{ V}, \qquad I_D = 1 \text{ A},$ | | 13 | 23 | ns |
| t _r | Turn–On Rise Time | V_{GS} = 10 V, R_{GEN} = 6 Ω | | 8 | 16 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 30 | 48 | ns |
| t _f | Turn-Off Fall Time | | | 25 | 40 | ns |
| Q_g | Total Gate Charge | $V_{DS} = 100 \text{ V}, \qquad I_{D} = 3.6 \text{ A},$ | | 27 | 43 | nC |
| Q_{gs} | Gate–Source Charge | V _{GS} = 10 V | | 7 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 10 | | nC |
| Drain-So | ource Diode Characteristics | and Maximum Ratings | | | | |
| Is | Maximum Continuous Drain-Source | Diode Forward Current | | | 2.1 | Α |
| V_{SD} | Drain–Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 2.1 \text{ A} \text{(Note 2)}$ | | 0.7 | 1.2 | V |

^{1.} $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

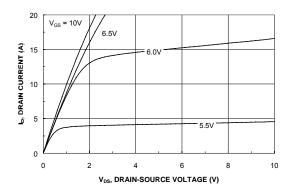


Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

3. $I_{SD} \leq 3A, \ di/dt \leq 100A/\mu s, \ V_{DD} \leq BV_{DSS}, \ Starting \ T_J$ = $25^{\circ}C$

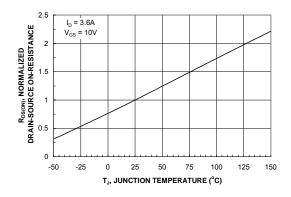
Typical Characteristics



1.6 OB- MESISTANCE ON-RESISTANCE ON-RESISTAN

Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



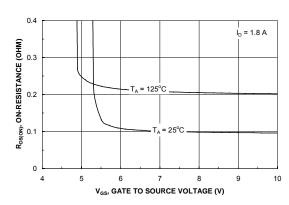
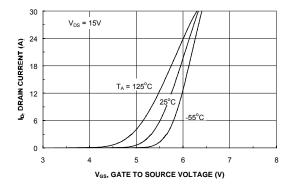


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



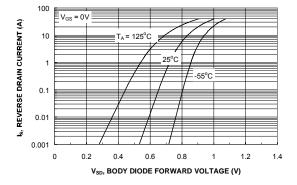
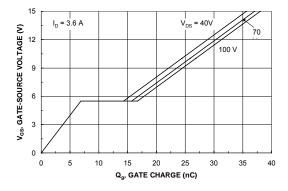


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



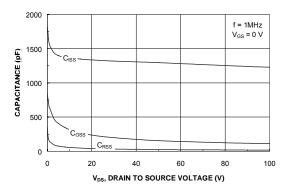
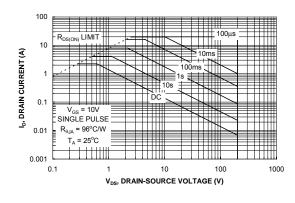


Figure 7. Gate Charge Characteristics.





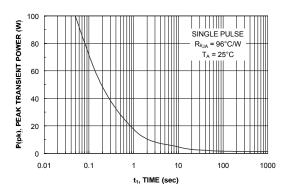


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

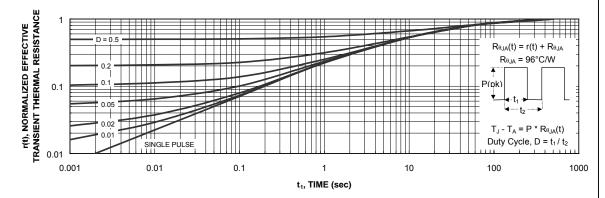


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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